Application/Control No. Applicant(s)/Patent Under Reexamination 10/659,748 NAKAMURA ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 Bradley K. Smith 2891 **U.S. PATENT DOCUMENTS** Document Number Date Name Classification Country Code-Number-Kind Code MM-YYYY US-5,714,399 02-1998 Hisatomi et al. 438/261 Α US-В US-С D US-US-Ε US-F US-G USн US-US-US-Κ US-L US-**FOREIGN PATENT DOCUMENTS** Document Number Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Р Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) Ofeenburg et al. Ultraclean, integrated processing of thermal oxide structures, Applied Physics Letters pp 1254-1256

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

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